

November 2007

FDJ129P

P-Channel -2.5 Vgs Specified PowerTrench® MOSFET

General Description

This P-Channel -2.5V specified MOSFET uses Fairchild's advanced low voltage PowerTrench process. It has been optimized for battery power management applications.

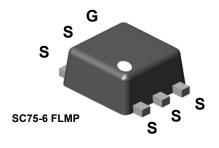
Applications

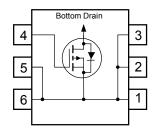
- · Battery management
- Load switch

Features

- -4.2 A, -20 V. $R_{DS(ON)}$ = 70 m Ω @ V_{GS} = -4.5 V $R_{DS(ON)}$ = 120 m Ω @ V_{GS} = -2.5 V
- · Low gate charge
- High performance trench technology for extremely low R_{DS(ON)}
- Compact industry standard SC75-6 surface mount package
- RoHS Compliant







Absolute Maximum Ratings TA=25°C unless otherwise noted

			_	
Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		± 12	V
I _D	Drain Current - Continuous	(Note 1a)	-4.2	А
	- Pulsed		-16	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.6	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R _{e,JA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	77	°C/W

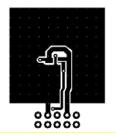
Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.A	FDJ129P	7"	8mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics	1	I	I		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μA,Referenced to 25°C		-18		mV/°(
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μА
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 12 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.6	-1.1	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = -250 μA,Referenced to 25°C		3		mV/°(
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -4.2 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -3.3 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -4.2, T_J = 125 ^{\circ}\text{C}$		54 91 72	70 120 100	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = -4.5 \text{ V}, I_D = -4.2, T_J = 125^{\circ}\text{C}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-8			Α
g FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -4.2 \text{ A}$		11		S
Dynamic	Characteristics					•
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		585	780	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		124	170	pF
C _{rss}	Reverse Transfer Capacitance	_		61	95	pF
Switchin	g Characteristics (Note 2)				•	
t _{d(on)}	Turn–On Delay Time	$V_{DD} = -10 \text{ V}, I_{D} = -1 \text{ A},$		10	20	ns
tr	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		9	18	ns
t _{d(off)}	Turn-Off Delay Time	1		17	30	ns
t _f	Turn–Off Fall Time			10	20	ns
Qg	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -4.2 \text{ A},$		4	6	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -4.5 V		1.1		nC
Q_{gd}	Gate-Drain Charge			1.2		nC
Drain-So	ource Diode Characteristics a	and Maximum Ratings				
V _{SD}	Drain-Source Diode Forwar Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.5 \text{ A} \text{(Note 2)}$		-0.7	-1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = -4.2 \text{ A},$		16		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		13		nC

Notes

1. R_{0,1A} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0,0} is guaranteed by design while R_{0,0} is determined by the user's board design.



a) 77°C/W when mounted on a 1in² pad of 2 oz copper.



b) 110°C/W when mounted on a minimum pad of 2 oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%

Typical Characteristics

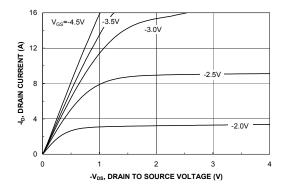


Figure 1. On-Region Characteristics.

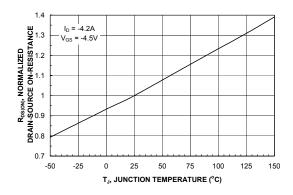


Figure 3. On-Resistance Variation withTemperature.

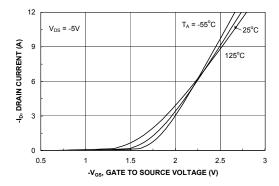


Figure 5. Transfer Characteristics.

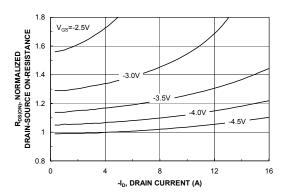


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

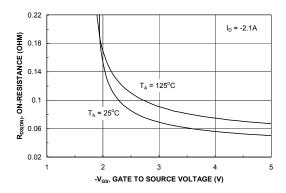


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

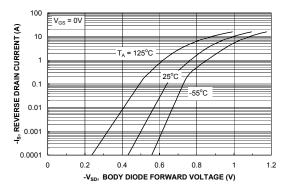
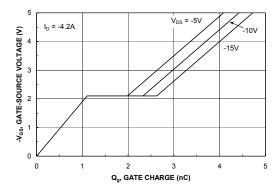


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



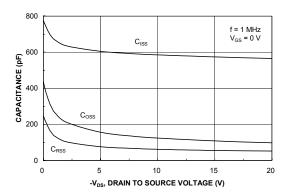
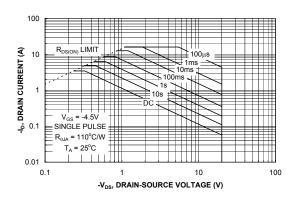


Figure 7. Gate Charge Characteristics.





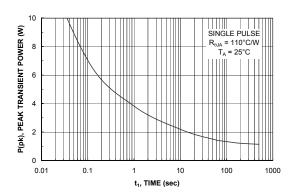


Figure 9. Maximum Safe Operating Area.



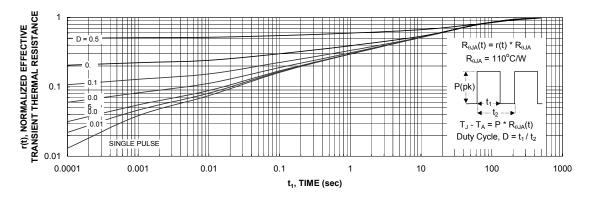


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

Dimensional Outline and Pad Layout PKG Œ PKG 0.30 MIN-Œ 6 DRAIN TERMINAL 2.35 MIN PKG L PKG Q 0.50 MIN 3 3 1 0.275 0.125 (0.20)0.50 ◆ 0.075M A B 1.00 0.50 LAND PATTERN RECOMMENDATION 1.00 PKG Ę PKG Œ 0.225 0.075 0.80 0.65 1.075 0.925 SEATING PLANE PKG (0.24)DRAIN NOTES: UNLESS OTHERWISE SPECIFIED NO PACKAGE STANDARD REFERENCE AS OF JULY 13, 2000. ALL DIMENSIONS ARE IN MILLIMETERS. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. PKG Q (0.75)(1.20)**BOTTOM VIEW**



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